

承 認 書 SPECIFICATION FOR APPROVAL

客戶名稱 CUSTOMER	:			
客戶料號 CUSTOMER'S P/N	:			
料號 PART NUMBER	: <u>WAN3216F2</u>	45HL6		
規格 DESCRIPTION	: Chip Antenna 3	216 L Ant 2.45G	Type HL6	
版本 VERSION	: <u>V1.1</u>			
日期 ISSUE DATE	: 2023/06/16		松	
		X		
	客戶承認 CUSTOMER APPROVED			
e	2	工程部 R&D CENTER		
one	承 認 APPROVAL	確認 CHECKED	製 作 DRAWN	
	Ray	Tennyson	Snow	





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OneWave Electronic Co., Ltd.

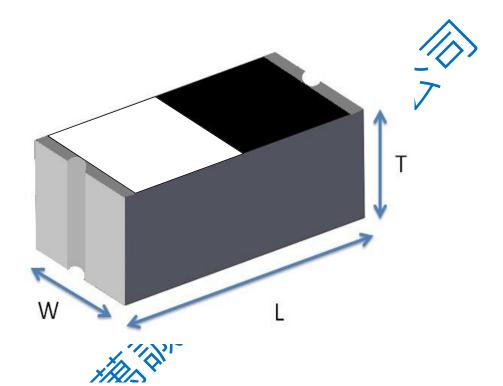
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3216 Chip antenna

For Bluetooth / WLAN Applications



P/N: WAN3216F245HL6

Ovenan

	Dimension (mm)	
L	3.20 ± 0.20	
W	1.60 ± 0.20	
T	1.00 ± 0.20	



Part Number Information

WAN 3216 F 245 H E F

Α	Product Series	Antenna
В	Dimension L x W	3.2 x 1.6mm (±0.2mm)
C	Material	High K material
D	Working Frequency	2.4 ~ 2.5GHz
E	Feeding mode	PIFA & Single Feeding
F	Antenna type	Type = L6

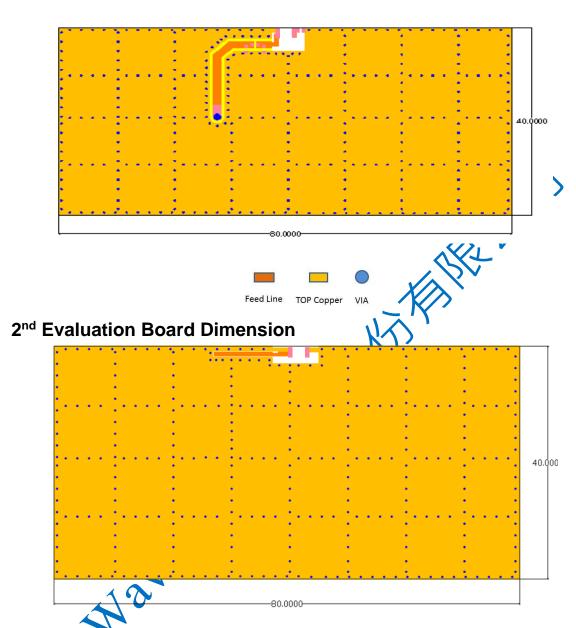
1. Electrical Specification

Specification			
Part Number	WAN3216F245HL6		
Central Frequency	2450	MHz	
Bandwidth	120 (Min.)	MHz	
Return Loss	-6.5 (Max)	dB	
Peak Gain	1.95	dBi	
Impedance	50	Ohm	
Operating Temperature	-40~+110	°C	
Maximum Power	4	W	
Resistance to Soldering Heats	10 (@ 260°C)	sec.	
		•	
Polarization	Linear		
Azimuth Beamwidth	Omni-directional		
Termination	Cu / Sn (Leadless)		

Remark: Bandwidth & Peak Gain was measured under evaluation board of next page



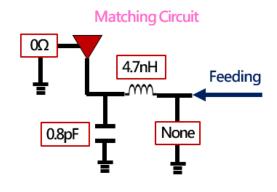
2. Recommended PCB Pattern Evaluation Board Dimension



Suggested Matching Circuit

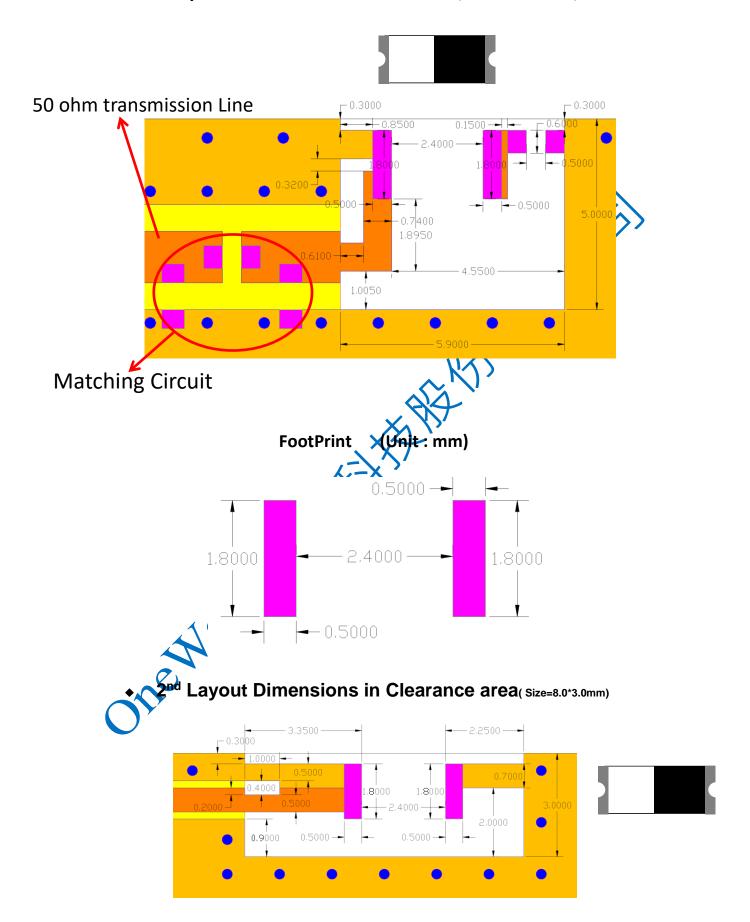
重要資訊:

匹配先件建議使用精準度高的電感±0.1~0.3nH、電容±0.1pF



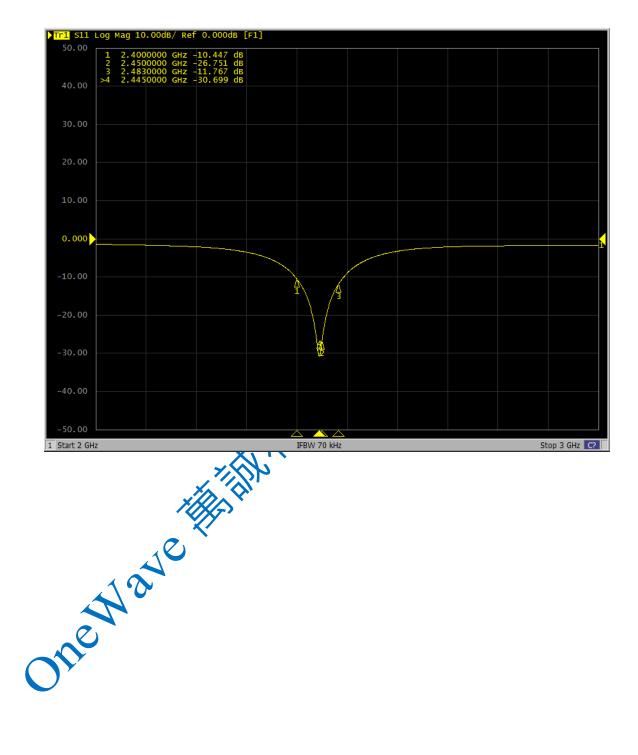


Layout Dimensions in Clearance area(Size=5.9*5.0mm)



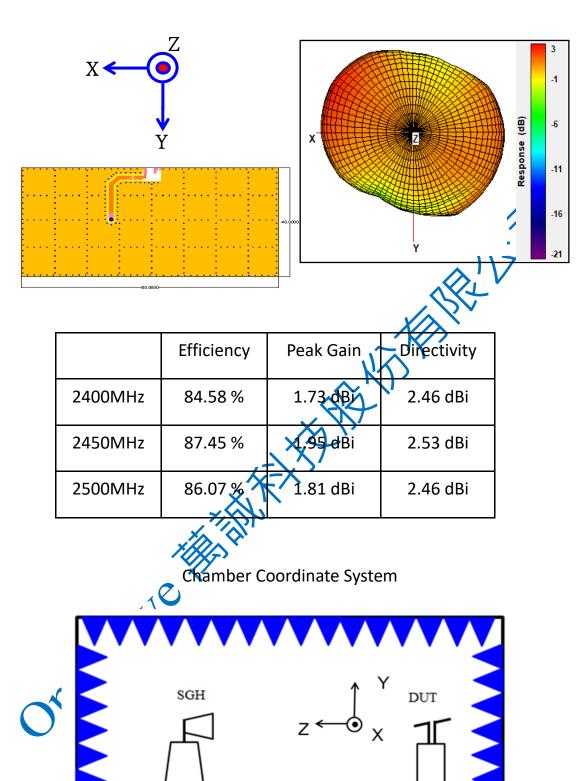


3. Measurement Results Return Loss





Radiation Pattern



Turning Support ←



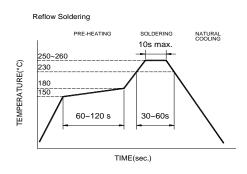
4.Reliability and Test Condictions

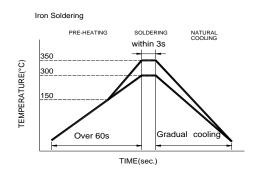
ITEM	REQUIREMENTS	TEST CONDITION
Solderability	Wetting shall exceed 90% coverage No visible mechanical damage	Pre-heating temperature:150°C /60sec.
	TEMP (℃)	Solder temperature:230 \pm 5 $^{\circ}$ C Duration:4 \pm 1sec.
		Solder:Sn-Ag3.0-Cu0.5
	230°C 4±1 sec.	Flux for lead free: rosin
	150°C	
	60sec	
Solder heat	No visible mechanical damage October Section 1. No visible mechanical damage	Pre-heating temperature:150°C /60sec.
Resistance	2. Central Freq. change :within ± 6%	Solder temperature:260±5°C Duration:10±0.5sec.
	TEMP (°C)	Solder:Sn-Ag3.0-Cu0.5
	260°C 10±0.5 sec.	Flux for lead free: rosin
	150°C	
	60sec	
	/ 00sec \	
Component	No visible mechanical damage	The device should be reflow
Adhesion (Push test)		soldered(280±5°C for 10sec.) to a tinned copper substrate A dynometer force
		gauge should be applied the side of the
		component. The device must with-ST-F
	× \	0.5 Kg without failure of the termination attached to component.
Component	No visible mechanical damage	Insert 10cm wire into the remaining open
Adhesion	,_\^\	eye bend ,the ends of even wire lengths upward and wind together.
(Pull test)	- * * * * * * * * * * * * * * * * * * *	Terminal shall not be remarkably
		damaged.
Thermal shock	No visible mechanical damage	+110°C=>30±3min
	2. Central Freq. change :within ±6%	-40°C=>30±3min Test cycle:10 cycles
	Phase Temperature(℃) Time(min)	The chip shall be stabilized at normal
	1 +110±5°C 30±3	condition for 2~3 hours before
	Room Within	measuring.
	Temperature 3sec 3 -40±2°C 30±3	
	4 Room Within	
	Temperature 3sec	
Resistance to	1. No visible mechanical damage	Temperature: +110±5°C
High	2. Central Freq. change :within ±6%	Duration: 1000±12hrs
Temperature	3. No disconnection or short circuit.	The chip shall be stabilized at normal condition for 2~3 hours before
		measuring.
Resistance to	1. No visible mechanical damage	Temperature:-40±5°C
Low	2. Central Freq. change :within ±6%	Duration: 1000±12hrs
Temperature	3. No disconnection or short circuit.	The chip shall be stabilized at normal condition for 2~3 hours before
		measuring.
Humidity	1. No visible mechanical damage	Temperature: 40±2°C
	2. Central Freq. change :within ±6%	Humidity: 90% to 95% RH
	3. No disconnection or short circuit.	Duration: 1000±12hrs The chip shall be stabilized at normal
		condition for 2~3 hours before
		measuring.



5. Soldering and Mounting

Mildly activated rosin fluxes are preferred. The minimum amount of solder can lead to damage from the stresses caused by the difference in coefficients of expansion between solder, chip and substrate. The terminations are suitable for all wave and re-flow soldering systems. If hand soldering cannot be avoided, the preferred technique is the utilization of hot air soldering tools.





Recommended temperature profiles for re-flow soldering in Figure 1.

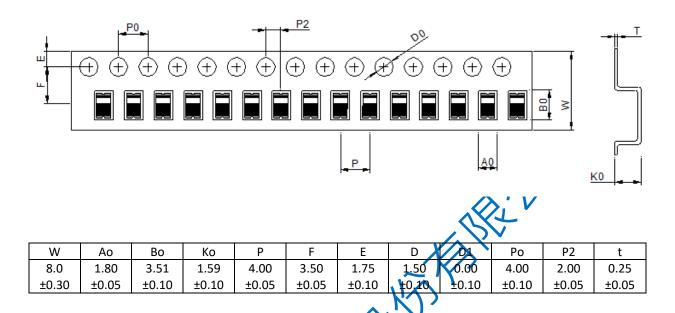
Products attachment with a soldering iron is discouraged due to the inherent process control limitations. In the event that a soldering iron must be employed the following precautions are recommended.

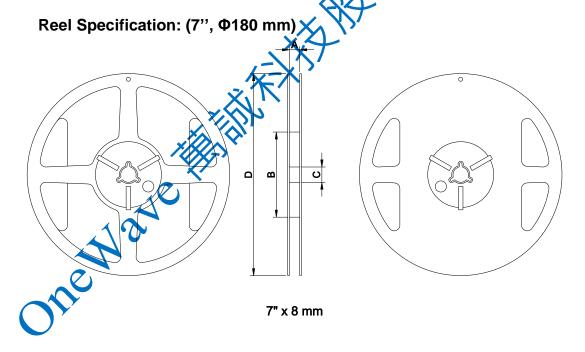
- Preheat circuit and products to 150°C
- Never contact the ceramic with the iron tip
- Use a 20 wattsoldering iron with tip diameter of 1.0mm
- 280° (tip temperature (max))
- 1.0mm tip diameter (max)
- Limit soldering time to 3 sec.



6.Packaging Information

Tape Specification:





Tape Width(mm)	A(mm)	B(mm)	C(mm)	D(mm)	Chip/Reel(pcs)
8	9.0±0.5	60±2	13.5±0.5	178±2	3000



7. Storage and Transportation Information

Storage Conditions

To maintain the solderability of terminal electrodes:

- 1. Temperature and humidity conditions: -10~ 40°C and 30~70% RH.
- 2. Recommended products should be used within 6 months from the time of delivery.
- 3. The packaging material should be kept where no chlorine or sulfur exists in the air.

Transportation Conditions

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- Products should be handled with care to avoid damage of contamination from perspiration and skin oils.
- 2. The use of tweezers or vacuum pick up is strongly recommended for individual components.
- 3. Bulk handling should ensure that abrasion and mechanical shock are minimized.